

direction. This produces another set of a plurality of scans, displaced from the first set of scans in the x direction.

[0030] Referring to both FIGS. 4 and 5, an alignment system 72 facilitates aligning workpiece 22 with respect to tool 24. Alignment is determined as a function of a circumference of fiducials present on workpiece 22, which is described in greater detail below with respect to FIG. 15. Referring again to both FIGS. 4 and 5, two fiducials are shown as 74. To that end, alignment system 72 includes an optical detector 72a and a laser range finder 72b. In signal communication with both detector 72a and laser range finder 72b is processing electronics 76. Processing electronics 76 receives signals from either detector 72a or laser range finder 72b and produces signals that may be processed by processor 34, which is in data communication therewith. With this arrangement, proper alignment between workpiece 22 and tool 24 may be ensured, thereby facilitating precisely registering an image, written by tool 24, with respect to workpiece 22.

[0031] Alignment system 72 cooperates with an illumination source, shown by dashed lines 78, to overcome a problem concerning reflection of electromagnetic radiation. Referring to FIG. 6, a problem was found in that light was reflected from fiducials 74 that hinders calculation of an accurate circumference of the same and, therefore, aligning workpiece 22 with tool 24.

[0032] Before a pattern is imaged on workpiece 22, a photo-sensitive layer 80 is disposed thereon. Also a layer of mylar 82 may be disposed on workpiece 22 to facilitate patterning of photo-sensitive layer 80. A portion of photo-sensitive layer 80 and mylar 82 often covers one or more of fiducials 74, creating what is referred to as a tented fiducial 84. As a result, electromagnetic radiation impinging thereon creates artifacts that are sensed by detector 72a, when employing standard illumination techniques.

[0033] Referring to FIGS. 5, 6 and 7, were top-down-dark-field illumination employed, a pattern 84a sensed by detector 72a includes artifacts 86 that are reflections from the uneven surface of tented fiducial 84. Artifacts 86a are bright regions, with surrounding regions 86b of pattern 84a being dark. As a result, determining the circumference of fiducial 74 is greatly hindered. Artifacts 86a define optical contrasting regions that hinder accurate determination of a fiducial circumference, because the width, w, of each of artifacts 86a may define a circumference that may vary $\pm w$. Thus, the circumference may be out of tolerance, resulting in fiducial 84 not being identified.

[0034] Referring to FIGS. 5 and 8, an analogous problem exists were top-down-bright-field illumination employed. A pattern 84b sensed by detector 72a employing top-down-bright-field illumination includes artifacts that are characterized as bright concentric rings 90a. Regions 90b surrounding rings 90a are dark. Determining the accurate circumference of pattern 84b is hindered by the difficulty in determining which of the rings define the circumference thereof.

[0035] To overcome this drawback, the present invention employs backlighting of fiducials 74 with sufficient electromagnetic flux impinging upon detector 72a to ensure any artifacts present in fiducials 74 are not sensed. As shown in FIG. 9, illumination source 78 emits electromagnetic radia-

tion 94 in the form of light that impinges upon fiducials 74. A sub-portion of radiation 94 passes through fiducials 74, and emerges therefrom as an emergent flux 96. Detector 72a senses the irradiance (watts/m²) of emergent flux 96 impinging thereupon and produces signals in response thereto that include information corresponding to one of fiducials 74. Processor 34 identifies the edge of emergent flux 96 by finding optically contrasting regions sensed by detector 72a. A boundary, typically annular in shape, is fitted to the shape of the edge identified by processor 34.

[0036] Referring to FIG. 9, artifacts produced by radiation 94 may be characterized as points 98 of dispersive radiation shown as rays 98a and 98b. The total power associated with rays 98a and 98b defines a radiant flux (watts). A sub-portion of the radiant flux, i.e., rays 98b, falls within the detection area of detector 72a, referred to as dispersive rays, while the remaining portion of the radiant flux, i.e., rays 98a, falls outside of the detection area, referred to as scattered rays. Thus, a component of emergent flux 96 includes dispersive rays 98b and, therefore, information corresponding to the artifacts. The power per unit area of dispersive rays 98b impinging upon detector 72a defines an irradiance. The remaining component of emergent flux 96 comprises the undispersed radiation, which includes information corresponding to fiducial 74. The power per unit area of the undispersed radiation defines an irradiance. However, radiation 94 is provided with sufficient power to ensure that the irradiance associated with the undispersed radiation is greater than the irradiance associated with dispersive rays 98b. Specifically, the relative irradiance between the undispersed radiation and dispersive rays 98b is such that the total irradiance sensed by detector 72a is substantially uniform across the detection area. In this manner, information corresponding to artifacts is attenuated and the irradiance sensed by detector 72a corresponds to electromagnetic radiation with substantially all the information contained therein corresponding to fiducial 74.

[0037] Referring to FIG. 10, an additional benefit provided by the present invention is that problems regarding misalignment of the features of fiducial 74 may be overcome. Specifically, as shown, often both sides of workpiece 22 are patterned, i.e., photo-sensitive material 80 and mylar 82 may be disposed on both sides. This requires proper alignment with respect to a common fiducial to ensure that the pattern on one side of the workpiece is registered properly with respect to the pattern on the opposing side. To that end, fiducial 74 is usually formed as a throughway extending between opposing sides of workpiece 22. The opposed ends of fiducial 74 terminate in an orifice, shown as 74a and 74b. However, fiducial 74 is formed by drilling or punching through workpiece 22. The drilling process often does not produce a perfectly cylindrical fiducial. As a result, orifices 74a and 74b disposed on opposing ends of fiducial 74 may not be centered on a common axis, shown as 100. Were top-down illumination employed, the circumference of the fiducial sensed by detector 72a, which is defined, for example, by orifice 74a, would be offset with respect to the circumference of fiducial 74, defined by orifice 74b. This situation hinders properly aligning the pattern on one side of workpiece 22 with respect to a pattern on the opposing side. The magnitude and position of the circumference of fiducial 74 is dependent of the side of workpiece 22 facing detector 72a.